




RADIO TEST REPORT


Test Report No. : 11554137S-A-R1

Applicant : CASIO COMPUTER CO., LTD.
Type of Equipment : Watch
Model No. : OCW-G2000
FCC ID : BBQS05W
Test regulation : FCC Part 15 Subpart C: 2016
Test Result : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. This report is a revised version of 11554137S-A. 11554137S-A is replaced with this report.

Date of test: November 11 to 24, 2016

Representative test engineer: 
Yosuke Ishikawa
Engineer
Consumer Technology Division

Approved by: 
Akio Hayashi
Leader
Consumer Technology Division



- The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.
 There is no testing item of "Non-accreditation".

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13-EM-F0429

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SECTION 1: Customer information

Company Name : CASIO COMPUTER CO., LTD.
Address : 2-1, Sakaecho 3 chome, Hamura-shi, Tokyo 205-8555 Japan
Telephone Number : +81-42-579-7282
Facsimile Number : +81-42-579-7702
Contact Person : Hiroaki Suzuki

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Watch
Model No. : OCW-G2000
Serial No. : Refer to Section 4, Clause 4.2
Rating : Typical: Nom : DC 2.5 V, Min.: DC 1.9 V, Max.: DC 2.7 V
CW5501 (Module): Min.: DC 1.9 V, Max.: DC 3.3 V
Receipt Date of Sample : October 26, 2016
Country of Mass-production : China, Thailand, Japan
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab.

2.2 Product Description

Model: OCW-G2000 (referred to as the EUT in this report) is a Watch.

* OCW-G2000 has alternative name as R001.

Clock frequency(ies) in the system : 32.768 kHz

Radio Specification

Equipment Type : Transceiver
Frequency of Operation : 2402 MHz - 2480 MHz
Type of Modulation : GFSK
Channel spacing : 2 MHz
Antenna Type : Chip Antenna
Antenna Gain : 2.5 dBi

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on November 14, 2016 and effective December 14, 2016

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

* The revision on November 14, 2016, does not affect the test specification applied to the EUT.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 8.8	FCC: Section 15.207 IC: RSS-Gen 8.8	-	-	NA *1)
6dB Bandwidth	FCC: KDB 558074 D01 DTS Meas Guidance v03r05 IC: -	FCC: Section 15.247(a)(2) IC: RSS-247 5.2(1)	See data.	Complied	Conducted
Maximum Peak Output Power	FCC: KDB 558074 D01 DTS Meas Guidance v03r05 IC: RSS-Gen 6.12	FCC: Section 15.247(b)(3) IC: RSS-247 5.4(4)		Complied	Conducted
Power Density	FCC: KDB 558074 D01 DTS Meas Guidance v03r05 IC: -	FCC: Section 15.247(e) IC: RSS-247 5.2(2)		Complied	Conducted
Spurious Emission Restricted Band Edges	FCC: KDB 558074 D01 DTS Meas Guidance v03r05 IC: RSS-Gen 6.13	FCC: Section 15.247(d) IC: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10	6.7 dB 9608.00 MHz, AV, Horizontal Tx 2402 MHz	Complied	Conducted (below 30 MHz)/ Radiated (above 30 MHz) *2)

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.
*1) The test is not applicable since the EUT has no AC mains.
*2) Radiated test was selected over 30 MHz based on section 15.247(d) and KDB 558074 D01 DTS Meas Guidance v03r05 12.2.7.

* In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.

FCC Part 15.31 (e)

The EUT provides stable voltage (DC 1.35 V) constantly to the wireless transmitter regardless of input voltage. Instead of a new battery, DC power supply was used for the test. That does not affect the test result, therefore the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 6.6	IC: -	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

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Item	Frequency range	Uncertainty (+/-)				
		No. 1 SAC / SR	No. 2 SAC / SR	No. 3 SAC / SR	No. 4 SAC / SR	No. 5,6,8 SR
Conducted emission (AC Mains) LISN	150 kHz-30 MHz	2.6 dB	2.5 dB	2.6 dB	2.5 dB	2.5 dB
Radiated emission (Measurement distance: 3 m)	9 kHz-30 MHz	3.1 dB	3.1 dB	3.1 dB	-	-
	30 MHz-200 MHz	4.6 dB	4.4 dB	4.6 dB	-	-
	200 MHz-1 GHz	5.8 dB	5.7 dB	5.8 dB	-	-
	1 GHz-13 GHz	4.9 dB	4.9 dB	4.9 dB	-	-
Radiated emission (Measurement distance: 1 m)	13 GHz-18 GHz	4.6 dB	4.6 dB	4.6 dB	-	-
	18 GHz-40 GHz	4.9 dB	4.9 dB	4.9 dB	-	-

SAC=Semi-Anechoic Chamber

SR= Shielded Room is applied besides radiated emission

Antenna terminal test	Uncertainty (+/-)
Power Measurement above 1 GHz (Average Detector)_SPM-06	0.72 dB
Power Measurement above 1 GHz (Peak Detector)_SPM-06	0.85 dB
Power Measurement above 1 GHz (Average Detector)_SPM-07	0.74 dB
Power Measurement above 1 GHz (Peak Detector)_SPM-07	0.91 dB
Spurious emission (Conducted) below 1GHz	1.6 dB
Spurious emission (Conducted) 1 GHz-3 GHz	1.3 dB
Spurious emission (Conducted) 3 GHz-18 GHz	2.2 dB
Spurious emission (Conducted) 18 GHz-26.5 GHz	2.3 dB
Spurious emission (Conducted) 26.5 GHz-40 GHz	2.4 dB
Bandwidth Measurement	1.01 %
Duty cycle and Time Measurement	0.012 %

Radiated emission test

The data listed in this test report has enough margin, more than the site margin.

3.5 Test Location

Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
No.1 Semi-anechoic chamber	2973D-1	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.2 Semi-anechoic chamber	2973D-2	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.3 Semi-anechoic chamber	2973D-3	12.7 x 7.7 x 5.35	12.7 x 7.7	5 m
No.4 Semi-anechoic chamber	-	8.1 x 5.1 x 3.55	8.1 x 5.1	-
No.1 Shielded room	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.2 Shielded room	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.3 Shielded room	-	6.3 x 4.7 x 2.7	6.3 x 4.7	-
No.4 Shielded room	-	4.4 x 4.7 x 2.7	4.4 x 4.7	-
No.5 Shielded room	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.6 Shielded room	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.8 shielded room	-	3.45 x 5.5 x 2.4	3.45 x 5.5	-
No.1 Measurement room	-	2.55 x 4.1 x 2.5	-	-

3.6 Test data, Test instruments, and Test set up

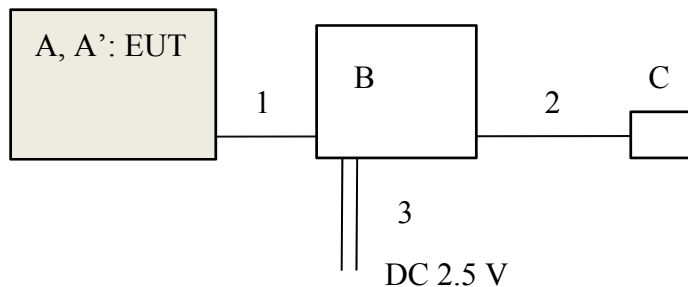
Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

Mode	Frequency	Remarks*
Bluetooth Low Energy	2402 MHz, 2440 MHz, 2480 MHz	PN9
<p>*Power of the EUT was set by the software as follows; Power settings: 0 dBm Software Version: RF_Test_Tool_Ver2.01</p> <p>*This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.</p>		

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Watch	OCW-G2000	67	CASIO	EUT *2)
A'	Watch	GPW-2000	87	CASIO	EUT *1)
B	Control Board	-	-	-	-
C	USB dongle	-	-	-	-

*1) Used for Antenna Terminal conducted test

*2) Used for Radiated Emission test

The result of antenna terminal conducted test is carried out with GPW-2000 because OCW-G2000 and GPW-2000 have same modules. These modules have same specification about firmware, channel, bandwidth, power setting. (GPW-2000 report is 11502772S-A)

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	Signal	0.1	Unshielded	Unshielded	*3)
2	Signal	0.1	Unshielded	Unshielded	-
3	DC	1.5	Unshielded	Unshielded	-

*3) Cable for test operation

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SECTION 5: Radiated Spurious Emission

Test Procedure

It was measured based on "11.0 Emissions in non-restricted frequency bands" of "558074 D01 DTS Meas Guidance v03r05".

[For below 1 GHz]

EUT was placed on a platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9(IC) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (IC).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV *1)	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	Average Power Method: RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces If duty cycle was less than 98%, a duty factor was added to the results.	RBW: 100 kHz VBW: 300kHz
Test Distance	3 m	3.95 m *2) (1 GHz – 13 GHz), 1 m *3) (13 GHz – 26.5 GHz)		3.95 m *2) (1 GHz – 13 GHz), 1 m *3) (13 GHz – 26.5 GHz)

*1) Average Power Measurement was performed based on 6.0 & 12.2.5 of "KDB 558074 D01 DTS Meas Guidance v03r05".

*2) Distance Factor: $20 \times \log(3.95 \text{ m} / 3.0 \text{ m}) = 2.39 \text{ dB}$

*3) Distance Factor: $20 \times \log(1.0 \text{ m} / 3.0 \text{ m}) = -9.54 \text{ dB}$

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The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Antenna polarization	Carrier	Spurious (Below 1 GHz)	Spurious (1 GHz -13 GHz)	Spurious (13 GHz -26.5 GHz)
Horizontal	Y	X	Y	X
Vertical	Y	Y	Y	X

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30 MHz - 26 GHz
Test data : APPENDIX
Test result : Pass

SECTION 6: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
6dB Bandwidth	10 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Sample	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak /Average *2)	-	Power Meter (Sensor: 50 MHz BW)
Peak Power Density	1.5 times the 6dB Bandwidth	3 kHz	9.1 kHz	Auto	Peak	Max Hold	Spectrum Analyzer *3)
Conducted Spurious Emission *4)	9kHz to 150kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150kHz to 30MHz	10 kHz	30 kHz				
*1) Peak hold was applied as Worst-case measurement. *2) Reference data *3) Section 10.2 Method PKPSD (peak PSD) of "KDB 558074 D01 DTS Meas Guidance v03r05". *4) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents. Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart. (9 kHz - 150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 10 kHz)							

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data : APPENDIX
Test result : Pass

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APPENDIX 1: Test data

6dB Bandwidth

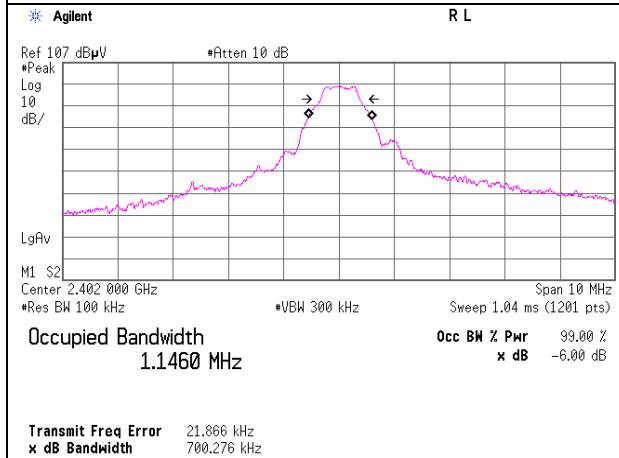
Test place	Shonan EMC Lab. No.3 Shielded Room
Report No.	11554137S-A-R1
Date	November 11, 2016
Temperature / Humidity	22 deg. C / 38 % RH
Engineer	Hiroyuki Morikawa
Mode	Tx BT LE

Mode	Frequency [MHz]	6dB Bandwidth [MHz]	Limit [kHz]
BT LE	2402	0.700	> 500
	2440	0.724	> 500
	2480	0.722	> 500

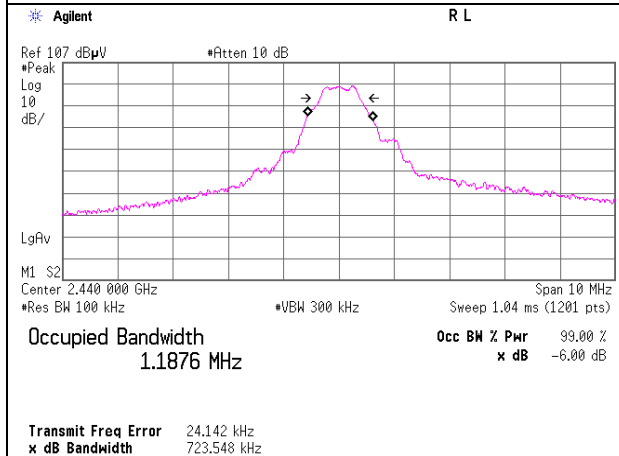
6dB Bandwidth

BT LE

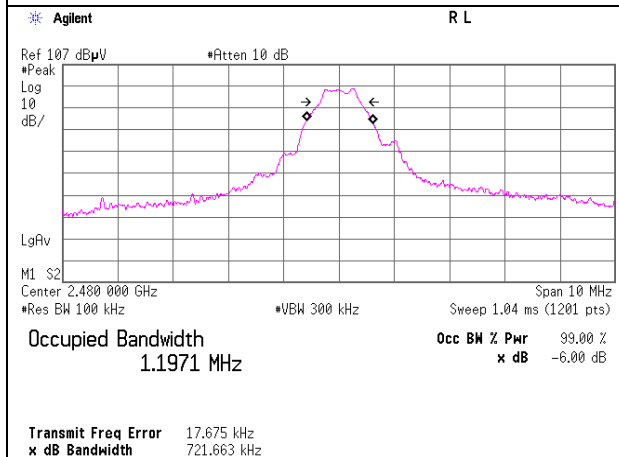
2402 MHz



2440 MHz



2480 MHz



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Maximum Peak Output Power

Test place Shonan EMC Lab. No.3 Shielded Room
Report No. 11554137S-A-R1
Date November 11, 2016
Temperature / Humidity 22 deg. C / 38 % RH
Engineer Hiroyuki Morikawa
Mode Tx BT LE

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
				[dBm]	[mW]	[dBm]	[mW]	
2402	-10.09	1.28	10.01	1.20	1.32	30.00	1000	28.80
2440	-10.23	1.29	10.01	1.07	1.28	30.00	1000	28.93
2480	-10.50	1.29	10.01	0.80	1.20	30.00	1000	29.20

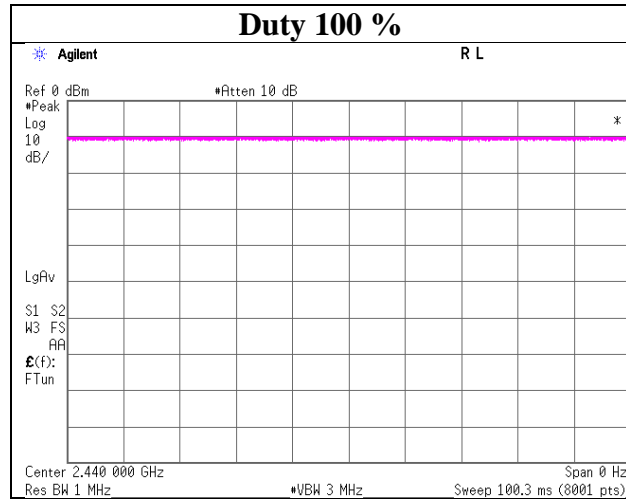
Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

*The equipment and cables were not used for factor 0 dB of the data sheets.

Burst rate confirmation

Test place	Shonan EMC Lab. No.3 Shielded Room
Report No.	11554137S-A-R1
Date	November 11, 2016
Temperature / Humidity	22 deg. C / 38 % RH
Engineer	Hiroyuki Morikawa
Mode	Tx BT LE



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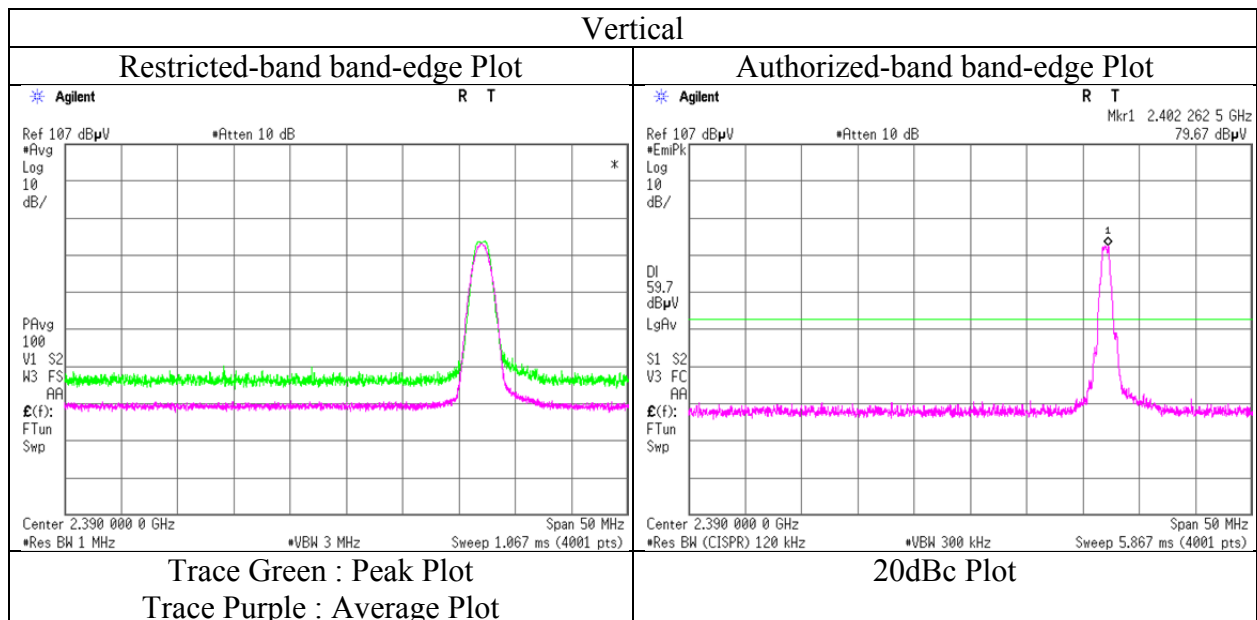
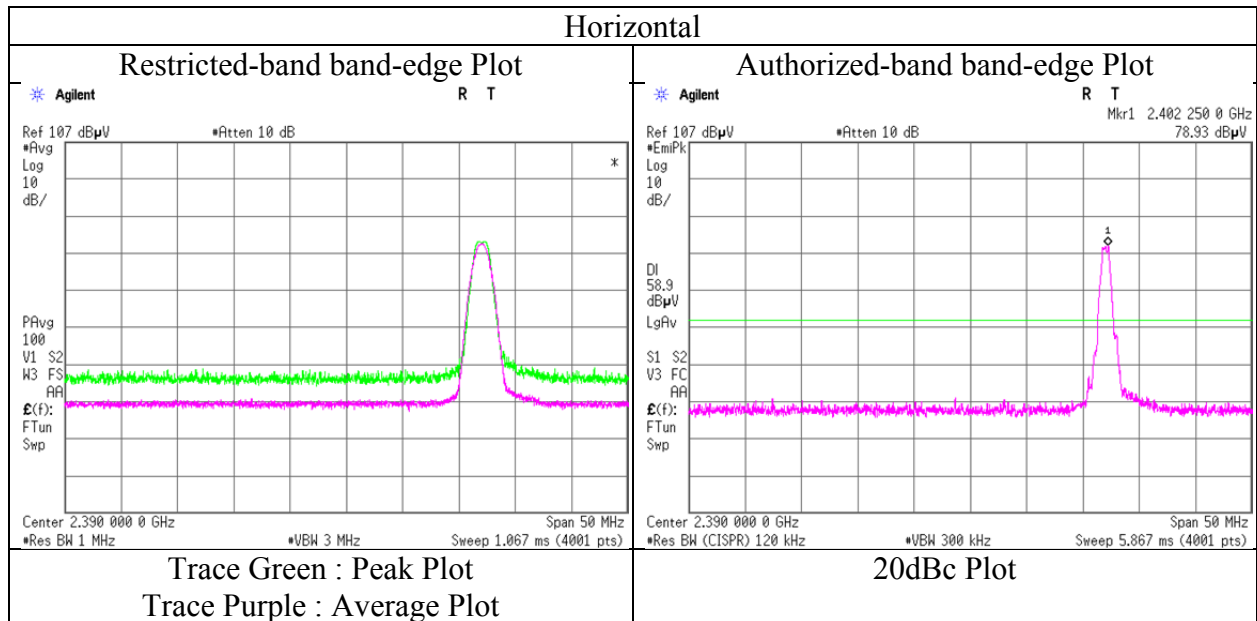
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Radiated Spurious Emission
(Reference Plot for band-edge)

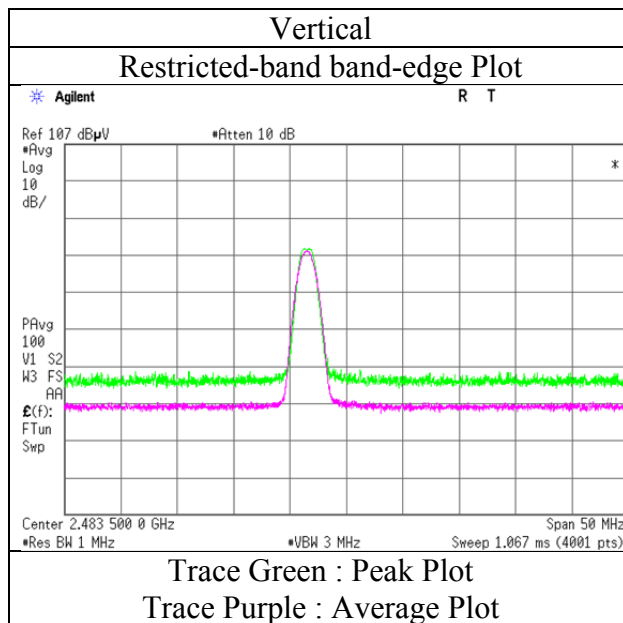
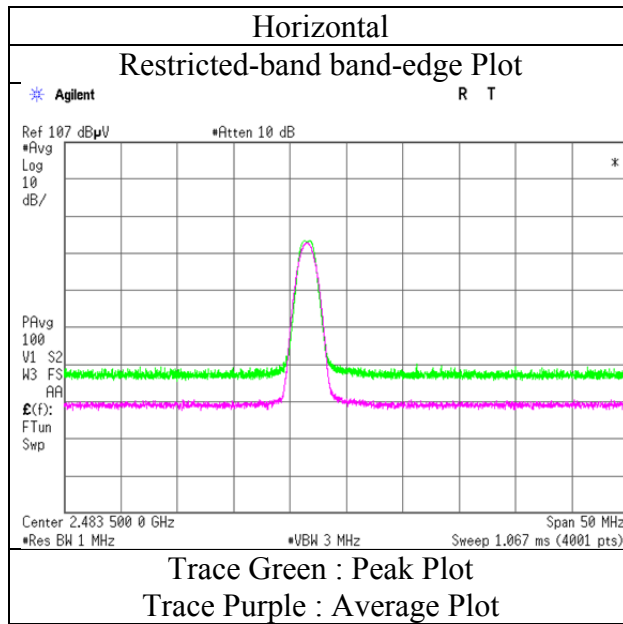
Test place : Shonan EMC Lab. No.3 Semi Anechoic Chamber
Report No. : 11554137S-A-R1
Date : November 24, 2016
Temperature / Humidity : 23 deg. C / 26 % RH
Engineer : Yosuke Ishikawa
(1 GHz -18 GHz)
Mode : Tx BT LE 2402 MHz



* Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission
(Reference Plot for band-edge)

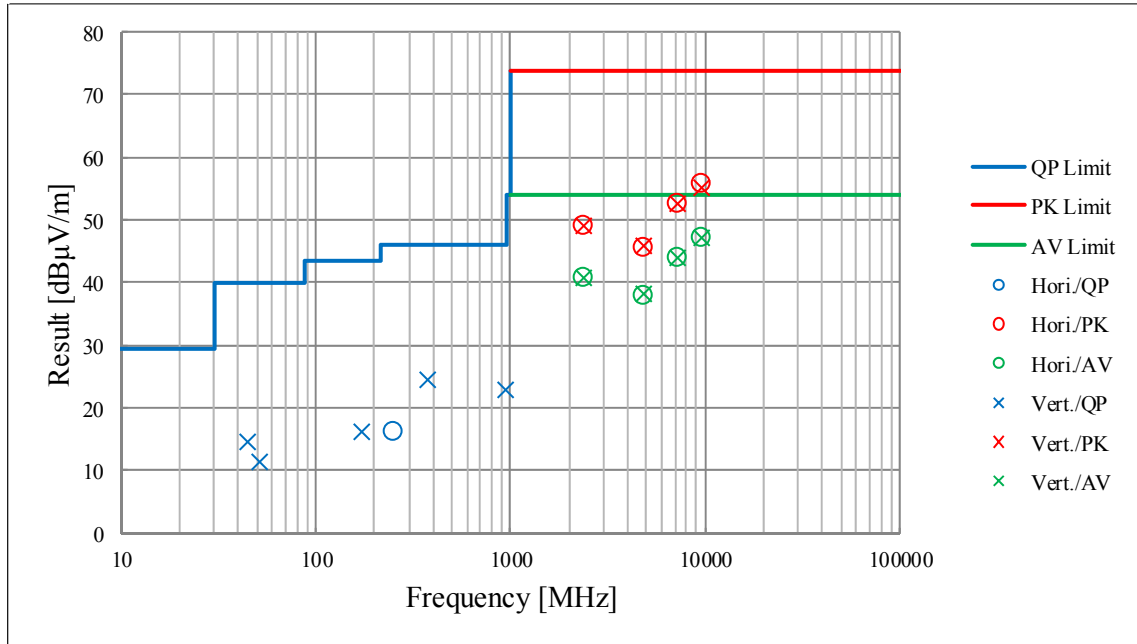
Test place : Shonan EMC Lab. No.3 Semi Anechoic Chamber
Report No. : 11554137S-A-R1
Date : November 24, 2016
Temperature / Humidity : 23 deg. C / 26 % RH
Engineer : Yosuke Ishikawa
(1 GHz -18 GHz)
Mode : Tx BT LE 2480 MHz



* Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission (Plot data, Worst case)

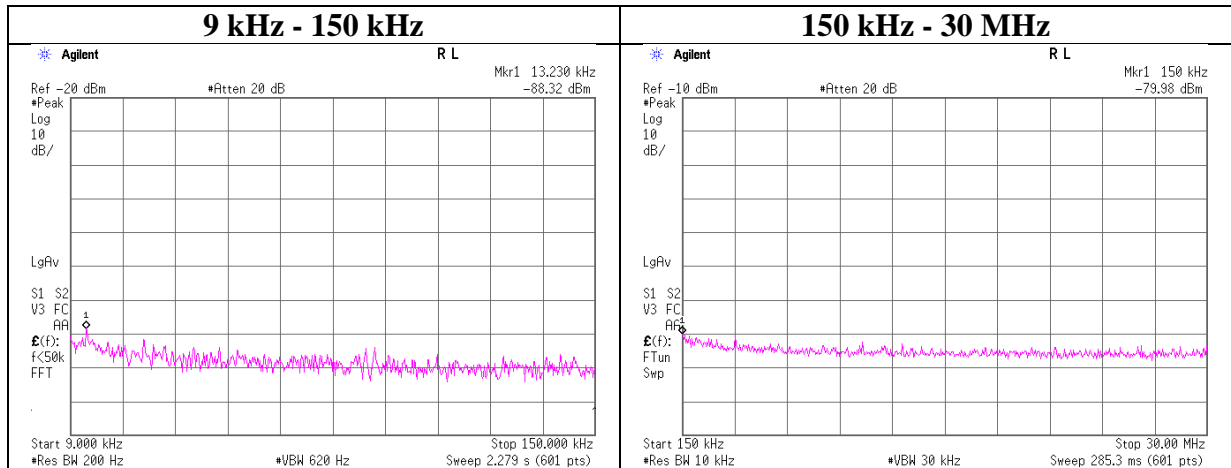
Test place	Shonan EMC Lab. No.1&3 Semi Anechoic Chamber	
Report No.	11554137S-A-R1	
Date	November 23, 2016	November 24, 2016
Anechoic Chamber	1	3
Temperature / Humidity	22 deg. C / 42 % RH	23 deg. C / 26 % RH
Engineer	Shinichi Takano (18 GHz -26 GHz)	Yosuke Ishikawa (1 GHz -18 GHz) (30 MHz -1000 MHz)
Mode	Tx BT LE 2402 MHz	



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

Conducted Spurious Emission

Test place	Shonan EMC Lab. No.3 Shielded Room
Report No.	11554137S-A-R1
Date	November 11, 2016
Temperature / Humidity	22 deg. C / 38 % RH
Engineer	Hiroyuki Morikawa
Mode	Tx BT LE 2402 MHz



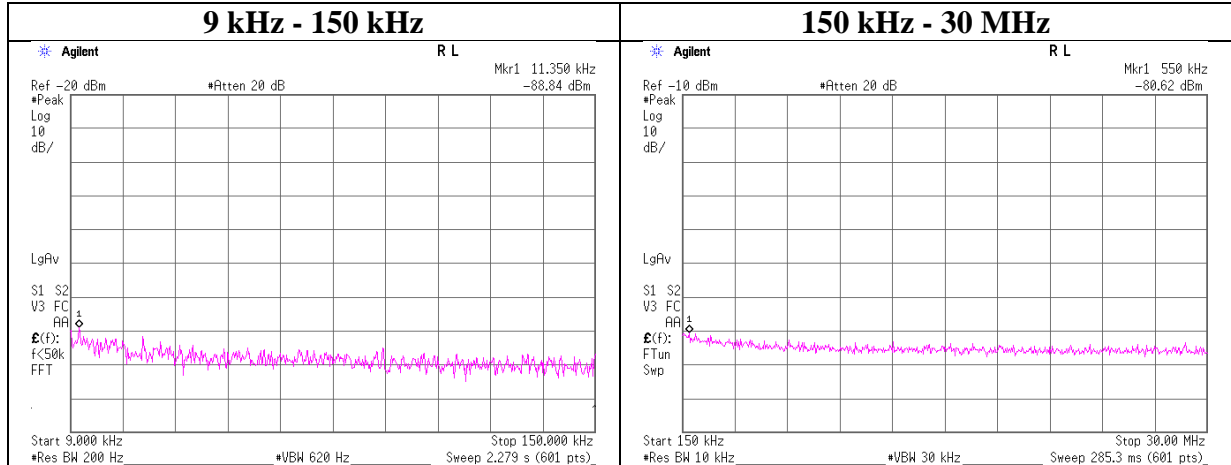
Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
13.23	-88.3	0.01	9.9	2.5	1	-75.9	300	6.0	-14.6	45.1	59.7	
150.00	-80.0	0.01	9.9	2.5	1	-67.5	300	6.0	-6.3	24.0	30.3	

$E = \text{EIRP} - 20 \log(D) + \text{Ground bounce} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP} = \text{Reading} + \text{Cable Loss} + \text{Attenuator Loss} + \text{Antenna Gain} + 10 * \log(N)$

Conducted Spurious Emission

Test place	Shonan EMC Lab. No.3 Shielded Room
Report No.	11554137S-A-R1
Date	November 11, 2016
Temperature / Humidity	22 deg. C / 38 % RH
Engineer	Hiroyuki Morikawa
Mode	Tx BT LE 2440 MHz



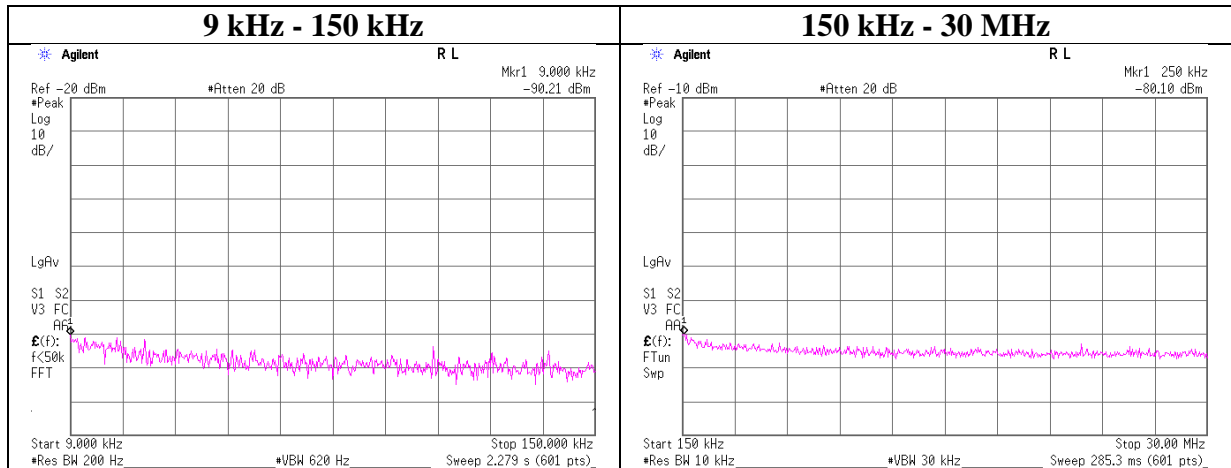
Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
11.35	-88.8	0.01	9.9	2.5	1	-76.4	300	6.0	-15.1	46.5	61.6	
550.00	-80.6	0.01	9.9	2.5	1	-68.2	30	6.0	13.1	32.7	19.6	

$E = \text{EIRP} - 20 \log(D) + \text{Ground bounce} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP} = \text{Reading} + \text{Cable Loss} + \text{Attenuator Loss} + \text{Antenna Gain} + 10 * \log(N)$

Conducted Spurious Emission

Test place	Shonan EMC Lab. No.3 Shielded Room
Report No.	11554137S-A-R1
Date	November 11, 2016
Temperature / Humidity	22 deg. C / 38 % RH
Engineer	Hiroyuki Morikawa
Mode	Tx BT LE 2480 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
9.00	-90.2	0.01	9.9	2.5	1	-77.8	300	6.0	-16.5	48.5	65.0	
250.00	-80.1	0.01	9.9	2.5	1	-67.7	300	6.0	-6.4	19.6	26.0	

$E = \text{EIRP} - 20 \log(D) + \text{Ground bounce} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP} = \text{Reading} + \text{Cable Loss} + \text{Attenuator Loss} + \text{Antenna Gain} + 10 * \log(N)$

Power Density

Test place Shonan EMC Lab. No.3 Shielded Room
Report No. 11554137S-A-R1
Date November 11, 2016
Temperature / Humidity 22 deg. C / 38 % RH
Engineer Hiroyuki Morikawa
Mode Tx BT LE

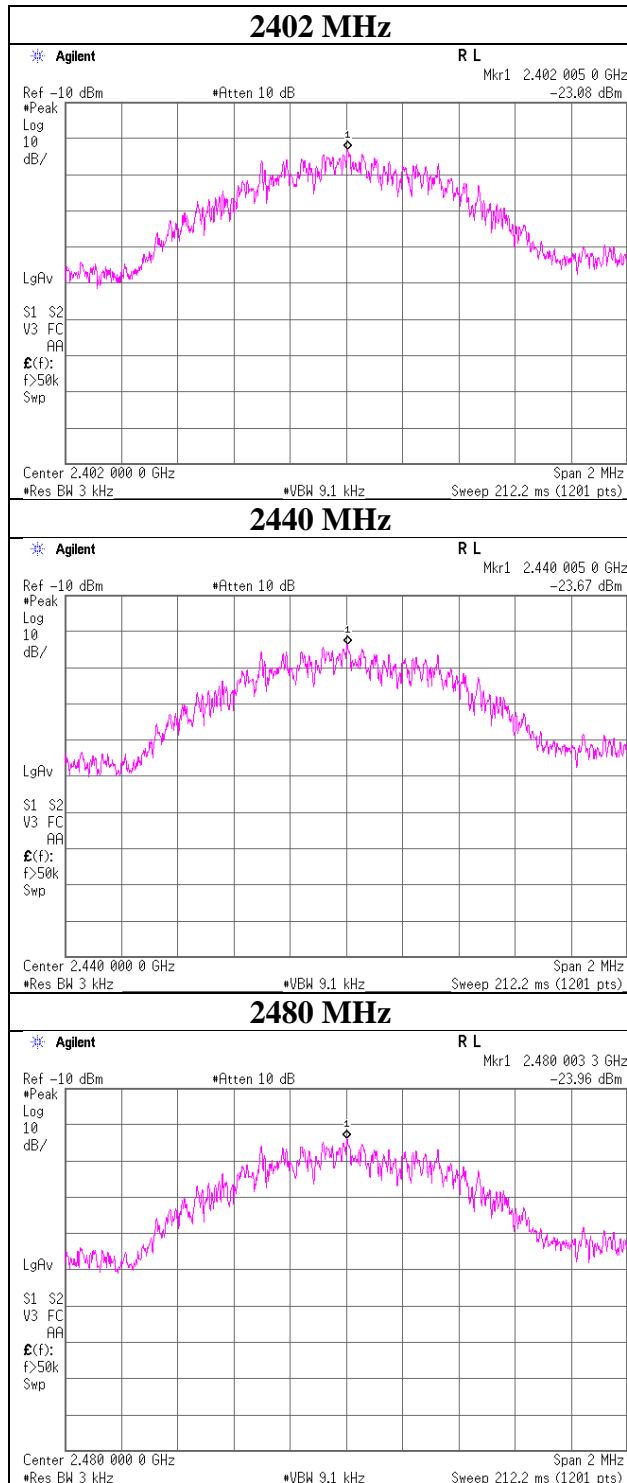
Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2402.00	-23.08	1.28	10.01	-11.79	8.00	19.79
2440.00	-23.67	1.29	10.01	-12.37	8.00	20.37
2480.00	-23.96	1.29	10.01	-12.66	8.00	20.66

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator

*The equipment and cables were not used for factor 0 dB of the data sheets.

Power Density



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Shonan EMC Lab.

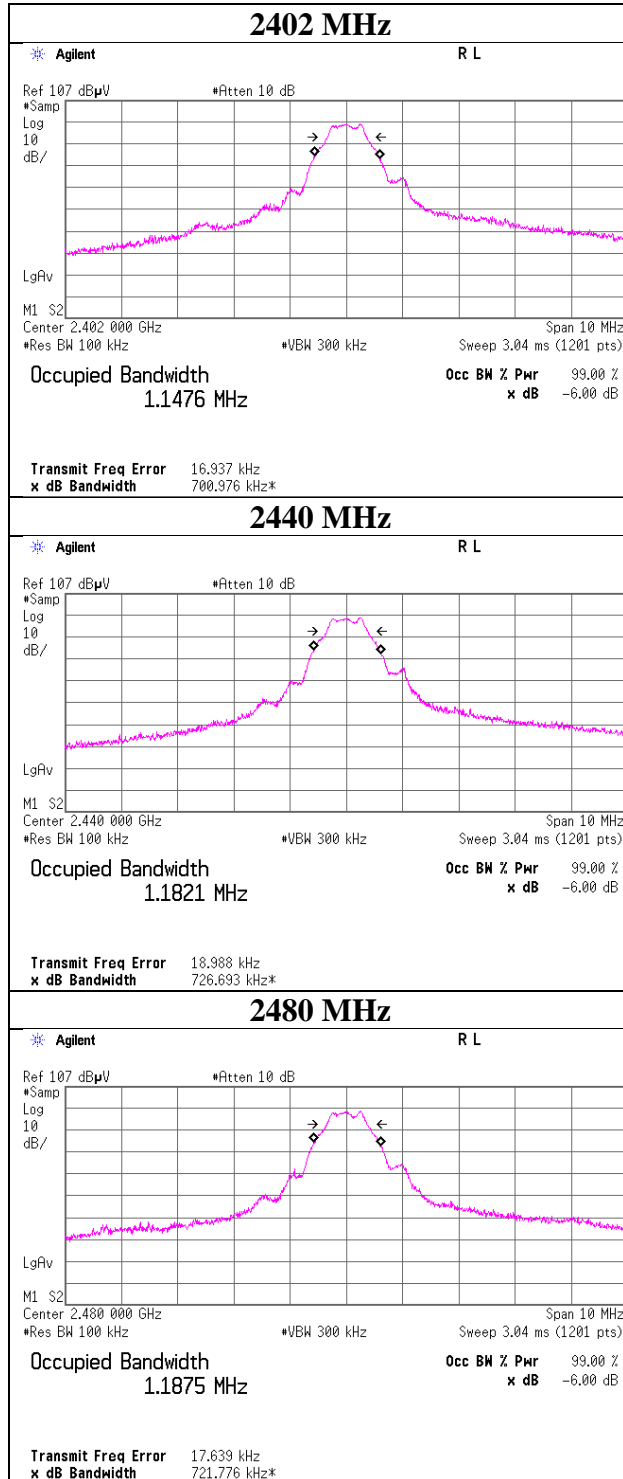
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

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99% Occupied Bandwidth

Test place	Shonan EMC Lab. No.3 Shielded Room
Report No.	11554137S-A-R1
Date	November 11, 2016
Temperature / Humidity	22 deg. C / 38 % RH
Engineer	Hiroyuki Morikawa
Mode	Tx BT LE



APPENDIX 2: Test instruments

Test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SAEC-01(NSA)	Semi-Anechoic Chamber	TDK	SAEC-01(NSA)	1	RE	2016/07/14 * 12
SHA-04	Horn Antenna	ETS LINDGREN	3160-09	LM3640	RE	2016/03/15 * 12
SOS-01	Humidity Indicator	A&D	AD-5681	4062555	RE	2016/10/12 * 12
SRENT-08	Spectrum Analyzer	Agilent	E4448A	MY50180019	RE	2016/10/24 * 12
KJM-09	Measure	KOMELON	KMC-36	-	RE	-
COTS-SEMI-1	EMI Software	TSJ	TEPTO-DV(RE ,CE,RFI,MF)	-	RE	-
STS-01	Digital Hitester	Hioki	3805-50	080997812	RE	2016/10/17 * 12
SCC-G15	Coaxial Cable	Suhner	SUCOFLEX 102	32703/2	RE	2016/03/08 * 12
SAF-08	Pre Amplifier	TOYO Corporation	HAP18-26W	00000019	RE	2016/03/23 * 12
SAF-04	Pre Amplifier	TOYO Corporation	TPA0118-36	1440489	RE	2016/03/22 * 12
SCC-G04	Coaxial Cable	Junkosha	J12J102207-00	JUN-12-14-0 18	RE	2016/06/23 * 12
SCC-G23	Coaxial Cable	Suhner	SUCOFLEX 104	297342/4	RE	2016/05/11 * 12
SHA-03	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-739	RE	2016/08/22 * 12
SOS-05	Humidity Indicator	A&D	AD-5681	4062518	RE	2016/10/12 * 12
SSA-02	Spectrum Analyzer	Agilent	E4448A	MY48250106	RE	2016/03/23 * 12
SJM-02	Measure	KOMELON	KMC-36	-	RE	-
SAEC-03(SVSWR)	Semi-Anechoic Chamber	TDK	SAEC-03(SVSWR)	3	RE	2016/07/25 * 12
COTS-SEMI-1	EMI Software	TSJ	TEPTO-DV(RE ,CE,RFI,MF)	-	RE	-
STS-03	Digital Hitester	Hioki	3805-50	080997823	RE	2016/10/17 * 12
SAT10-06	Attenuator	Agilent	8493C-010	74865	RE, AT	2016/11/07 * 12
SFL-02	Highpass Filter	MICRO-TRONICS	HPM50111	051	RE	2016/11/29 * 12
SAEC-03(NSA)	Semi-Anechoic Chamber	TDK	SAEC-03(NSA)	3	RE	2016/07/15 * 12
SBA-03	Biconical Antenna	Schwarzbeck	BBA9106	91032666	RE	2016/10/18 * 12
SLA-07	Logperiodic Antenna	Schwarzbeck	VUSLP9111B	196	RE	2016/01/30 * 12
SAT6-08	Attenuator	HIROSE ELECTRIC CO.,LTD.	AT-406(40)	-	RE	2016/08/04 * 12
SCC-C1/C2/C3/C4/C5/C10/SRSE-03	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhner /Suhner/Suhner/Suhner/T OYO	8D2W/12DSFA /141PE/141PE/ 141PE/141PE/ NS4906	-/0901-271(R F Selector)	RE	2016/04/22 * 12
SAF-03	Pre Amplifier	SONOMA	310N	290213	RE	2016/02/25 * 12
STR-06	Test Receiver	Rohde & Schwarz	ESCI	101259	RE	2016/03/28 * 12
SPM-06	Power Meter	Anritsu	ML2495A	0850009	AT	2016/04/01 * 12
SPSS-03	Power sensor	Anritsu	MA2411B	0917063	AT	2016/04/01 * 12
SSA-03	Spectrum Analyzer	Agilent	E4448A	MY48250152	AT	2016/09/26 * 12
SCC-G12	Coaxial Cable	Suhner	SUCOFLEX 102	30790/2	AT	2016/03/23 * 12
SOS-06	Humidity Indicator	A&D	AD-5681	4062118	AT	2015/12/07 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

**Test Item: RE: Radiated Emission test
AT: Antenna Terminal Conducted test**

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